Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/808,283	HANS, HELMUT
Examiner	Art Unit
Tran N. Nguyen	2834

SEARCHED					
Class	Subclass	Date	Examiner		
310	156.53	3/3/2	A		
	156.56	105	M		
	156.57				
	156.74				
	156,76				
	156.84	17	A2		
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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